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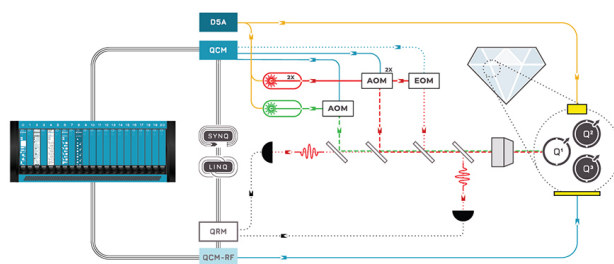
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ABSTRACT

Creating a good contact between electrodes and graphene nanoribbons (GNRs) has been a long-standing challenge in searching for the next GNR-based nanoelectronics. This quest requires the controlled fabrication of sub-20 nm metallic gaps, a clean GNR transfer minimizing damage and organic contamination during the device fabrication, as well as work function matching to minimize the contact resistance. Here, we transfer 9-atom-wide armchair-edged GNRs (9-AGNRs) grown on Au(111)/mica substrates to pre-patterned platinum electrodes, yielding polymer-free 9-AGNR field-effect transistor devices. Our devices have a resistance in the range of 10^6 – 10^8 Ω in the low-bias regime, which is 2–4 orders of magnitude lower than previous reports. Density functional theory calculations combined with the non-equilibrium Green's function method explain the observed p-type electrical characteristics and further demonstrate that platinum gives strong coupling and higher transmission in comparison to other materials, such as graphene.

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Atomically precise graphene nanoribbons (GNRs) are a family of graphene-based quantum materials which have been predicted to host exotic physical properties and potential electronic applications.¹ Depending on their sizes and terminations, they can manifest magnetically ordered edges,^{2–4} tunable band-gaps,^{5–7} or high-charge mobility.⁸ Properties, such as bandgap tunability, topological properties, as well as edge magnetism^{9–11} and others are intrinsic to GNRs and only appear when atomic precision in the synthesis is achieved. To translate these properties into devices, transfer of the ribbons to an appropriate substrate and creation of a good electrical contact between the GNRs and the electrodes are crucial.

Two main contact approaches have been investigated so far in the literature. One is achieved by the direct deposition of electrodes on top of GNRs with lithographic tools.^{12–16} GNR devices fabricated with this top-contact approach show high, non-Ohmic contacts, and in some cases, the current is limited by the contact resistance.^{12,13,15} This indicates a poor contact of the GNRs with the possible presence of a large Schottky barrier. Additionally, these top-contact GNR devices

can suffer from resist contamination and heating during metal evaporation in the lithography process. This is particularly destructive for the GNRs with reactive edges, such as spin-polarized edges and topologically protected edgestates.^{11,17,18}

Another approach for contacting GNRs is by transferring GNRs onto pre-patterned electrodes. For GNRs grown on Au-mica substrates, a polymer-free transfer of 9-atom-wide armchair-edged GNRs (9-AGNRs) has been optimized and used in previous reports of Refs. 14 and 19 and Ref. 20 with Pd and graphene electrodes, respectively. However, in the case of Pd nanogaps, large Schottky barriers limited the transport through these devices. Likewise, graphene electrodes did not solve the issue of contact resistance and introduced more uncertainties related to the fabrication, i.e., not well-defined gap sizes and lithography-related PMMA residues on the electrodes, the latter being a known concern for graphene devices.²¹

In this Letter, we study 9-AGNRs junctions with pre-patterned Pt electrodes forming nanogap ranging from 20 to 100 nm in width and 1 μm in length. We transfer the 9-AGNRs after the nanogap

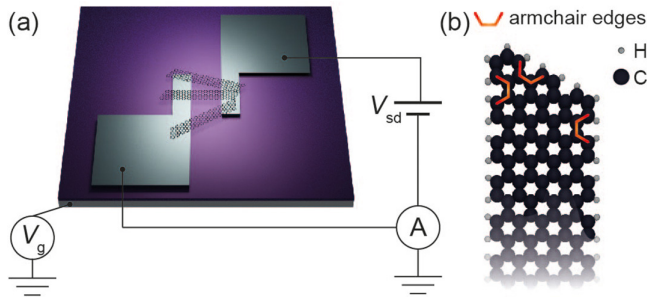


FIG. 1. Device schematics: (a) 9-AGNR field effect transistor device with Pt electrodes and SiO_2 as the back gate oxide. (b) Atomic structure of 9-AGNR. The armchair termination is indicated by the red lines in the structure.

fabrication and show GNR devices with low-bias (200 mV) Ohmic resistance in the range of 10^6 – $10^8 \Omega$, orders of magnitude lower than the previous reports.^{12–15,20} Approximately 100% device yield and low resistance are realized as a result of a cleaner device fabrication process compared to the previous top-contact approach, where GNRs are subjected to polymer contamination and high process temperatures. With the field effect transistor geometry, we further demonstrate the high transmission in the Pt–GNR–Pt junctions with p-type transport properties, concluded from gate-dependent measurements. These observations are rationalized by density functional theory and non-equilibrium Green's function formalism (DFT + NEGF) calculations, establishing platinum as an excellent material for contacting 9-AGNRs.

We employ a field-effect transistor geometry to electrically characterize 9-AGNRs in a vacuum probe station. A schematic device layout is illustrated in Fig. 1(a). With this geometry we measure the current–voltage (I – V) characteristics of 9-AGNRs as well as their gate dependence (I – V_g). The GNRs are transferred onto pre-patterned Pt gaps on a SiO_2/Si substrate, where the Si wafer is used as a global back-gate electrode. The 9-AGNRs form transport channels by bridging the pre-patterned lithographically defined Pt nanogaps. The atomic structure of 9-AGNRs is also shown in Fig. 1(b), where the four sides of the GNRs are armchair-terminated.

To form a clean 9-AGNR-electrode interface, we pattern Pt electrodes prior to introducing the GNRs, thus avoiding organic contamination of the junction. The device fabrication steps are shown in Fig. 2. We use a SiO_2/Si substrate with a thermal oxide thickness of 285 nm. The substrates are first cleaned with acetone and isopropyl alcohol (IPA) for 5 min each to remove organic residues on the surface. Subsequently, the substrate is cleaned with an oxygen plasma at a power of 300 W for 3 min. After the cleaning, the substrate is spin-coated with PMMA 950K A2 (MicroChem) at 3000 rpm and baked at 180°C for 3 min on a hot plate. This gives a resist thickness of about 80 nm.

The nanogaps with various widths (20–100 nm by design) are patterned by EBPG5000+ (Raith) with an acceleration voltage of 100 kV. To form well-defined nanogaps, a high dose at $2100 \mu\text{C}/\text{cm}^2$ is chosen together with a cold development technique. The nanogap structure is developed in IPA:MIBK (3:1) at a temperature of -20°C for 3 min. Afterward, the electrodes are made by electron-beam evaporation of 3 nm of Ti at a rate of $0.5 \text{ \AA}/\text{s}$ and 17 nm of Pt at a rate of 1 nm/s, followed by a liftoff process in hot acetone at 50°C . With this thin PMMA resist layer and the cold development method, we achieve Pt nanogap as small as 20 nm with an aspect ratio of more than 100. This allows the possibility to measure end-to-end connected GNRs as they are in the length of few tens of nanometers [see Fig. S1(a) for a STM image of 9-AGNRs on Au(111)]. Moreover, the large aspect ratio provides a high device yield as several 9-AGNRs can be connected in the same junction. Similar nanogaps with large aspect ratio can also be achieved with other methods but require a more elaborated technique, such as a chromium oxide mask.²²

To transfer the 9-AGNRs onto the pre-patterned substrate, we follow the polymer-free transfer process described elsewhere.^{15,23,24} In short, an Au film containing 9-AGNRs delaminates itself from its mica substrate when placed onto an aqueous HCl solution. Afterward, a pre-patterned substrate is used to pull out the free-standing Au film from the diluted HCl solution [Fig. 2(e)]. To remove the Au film from the 9-AGNRs, the substrate with Au film is covered with a gold etchant for 5 min, as shown in Fig. 2(f), and subsequently rinsed with de-ionized water and cleaned with acetone and IPA. This transfer process

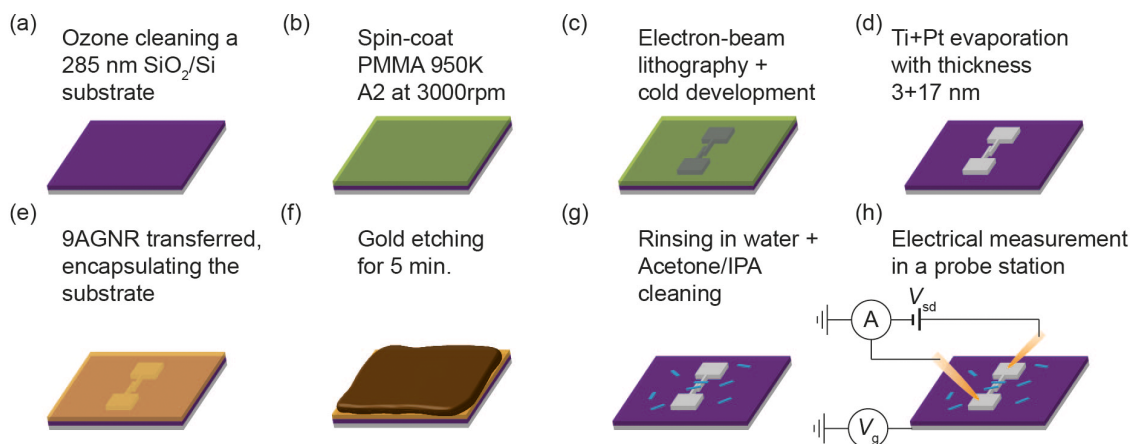


FIG. 2. Fabrication steps: (a)–(d) the pre-patterning of the Pt nanogap. (e)–(g) Polymer-free transfer of 9-AGNR. (h) Electrical measurements in a probe station. The blue lines represent the 9-AGNRs.

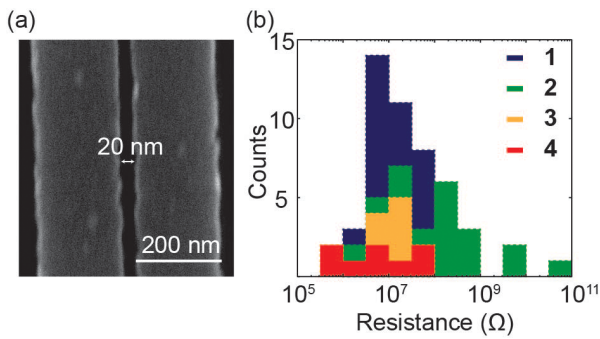


FIG. 3. (a) Scanning electron microscopy image of Pt nanogap, with a feature size of 20 nm. (b) Resistance determined at a bias voltage of 50 mV for four different samples with several devices on each of them. With the ribbon density of 0.02 nm^{-1} , we have estimated 255.7, 220.0, 91.1, and 42.0 ribbons for 20, 50, 80, and 100-nm nanogaps, respectively.

preserves the 9-AGNR quality as no peak shift in the Raman spectra of 9-AGNRs was observed, before and after the transfer [Fig. S1(b)]. Afterward, the sample is mounted in a vacuum probe station at room temperature for electrical characterization.

Figure 3(a) shows a scanning electron microscopy (SEM) image of a typical Pt nanogap with a feature size of 20 nm. 9-AGNRs with an average length of 45 nm and maximum lengths up to 100 nm are transferred onto these nanogaps, forming Pt-9-AGNR-Pt junctions. Here, we present electrical measurements of four different substrates, each contains multiple devices. Figure 3(b) summarizes the resistance of these junctions at 50 mV with all nanogap sizes. The junctions have a most probable low-bias resistance around $10^7 \Omega$, orders of magnitude lower than that in previous reports.^{12–15,20} We also compare the low-bias resistance between junctions, made with a polymer-free transfer and PMMA-assisted transfer techniques on the same substrate (see Fig. S2). Consistently, the PMMA-assisted transferred junctions show a resistance that is 1–2 orders of magnitude higher, showing a clear influence of the use of PMMA on the transport properties, possibly due to different doping levels and contamination at the interfaces.

It is worth noting that the yield is nearly 100% for electrically conducting junctions, i.e., $R < 10 \text{ G}\Omega$ after GNR transfer. All devices were previously verified to be insulating. The large 9-AGNR/Pt contact area [$1 \mu\text{m}$ in vertical direction of Fig. 3(a)] may be of importance in this observation. A high yield benefiting from a large junction contact area was also observed previously, even in devices with μm -size gaps.²⁵ This implies that the Pt-9-AGNR junctions comprise a network of GNRs, where a distance-dependent resistance is expected.²⁵ However, with the large spread in the resistance distribution, we do not observe significant difference in the low-bias resistance for devices with different nanogap sizes ranging from 20 to 100 nm (see Fig. S3). This large spread in resistance also hinders the contribution from higher numbers of ribbons in small nanogaps (see caption of Fig. 3 for the estimated number of ribbons in each gap). We clearly see that the limiting factor of the transport is neither the width of nanogap nor the number of ribbons in the nanogap. This is consistent with the observations in previous reports for short-channel devices where large spread in resistance was also observed and attributed the dominant transport mechanism to the high contact resistance.^{20,26,27}

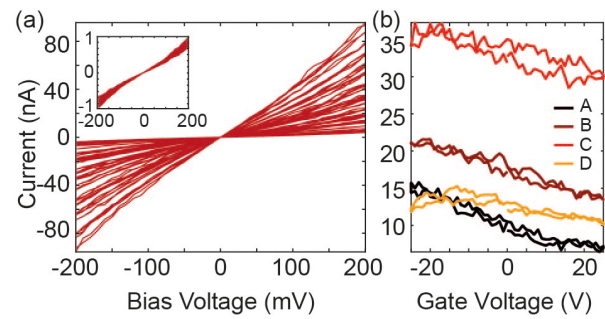


FIG. 4. (a) I - V characteristics of 36 junctions in sample 1 within a bias voltage range of $\pm 200 \text{ mV}$. The inset shows the normalized I - V characteristics. (b) Gate traces of four different junctions in sample 1, taken at a bias voltage of 100 mV.

To gain more insight into charge transport in the 9-AGNR devices, we show the I - V characteristics of sample 1 in Fig. 4 (see Fig. S4 for other samples). The current shows a linear dependence on the bias voltage within the range of $\pm 200 \text{ mV}$. To probe the linearity of the I - V characteristics, we have applied a bias voltage up to 1 V, shown in Fig. S5 for sample 2. This bias limit is chosen to prevent the possible creation of filamentary paths in silicon oxide, which can occur at a few Volts applied across thin oxide layers.²⁸ In this case, we observe non-linearity taking place typically around a few hundred mV. The low resistance I - V of these pre-patterned Pt-9-AGNR-Pt junctions at low-bias without gating can be a result of a better work function matching in comparison to previously investigated electrode materials.^{12–15,20}

Figure 4(b) shows the gate dependent current at a bias voltage of 100 mV. From the ratio of the maximum and minimum current for gate voltages ranging from -20 to 20 V , the on-off ratio is determined: $R_{\text{on-off}} = I_{\text{max}}/I_{\text{min}}$. We obtain small $R_{\text{on-off}} < 10$ for sample 1. The highest on-off ratio of 25 is observed in sample 3, shown in Fig. S6(d). Additional gate traces at a higher bias voltage of 1 V for sample 2 are shown in Fig. S7, where a maximum $R_{\text{on-off}}$ of 30 is observed. A crucial observation in the gate traces, consistent p-type transport, which is consistent with previous observations in 9-AGNR-based transistors.^{12–16,20,25}

The small gate dependence and on-off ratio of the current illustrate the poor gate efficiency of the 9-AGNR junctions. This poor efficiency may come from three contributions: (i) The electric field is screened by the metallic electrodes between the gate and GNR and screened between GNR and GNR. These screening effects were demonstrated by simulations previously in Ref. 16, where the electrostatic potential was completely screened in a densely packed GNR film with a GNR separation of 1.5 nm. It was also shown that a 20 nm nanogap is screened for more than 50% with an electrode thickness of 4 nm without the presence of GNRs.¹⁶ This suggests that the densely packed 9-AGNR devices with a metal electrode height of 20 nm can be screened efficiently, leading to the observed poor gate efficiency. (ii) The low gate coupling is partially due to the low dielectric constant of the silicon oxide and the thick oxide thickness. An improvement for future experiments can be made by using a thin, high- κ gate oxide, such as HfO_2 .^{14,16,19} (iii) The transport mechanism can be dominated by a hopping-like mechanism with an intrinsic low gate coupling. A temperature dependent measurement is necessary to elucidate the transport mechanism in these GNR devices, which is a subject of study for the future.

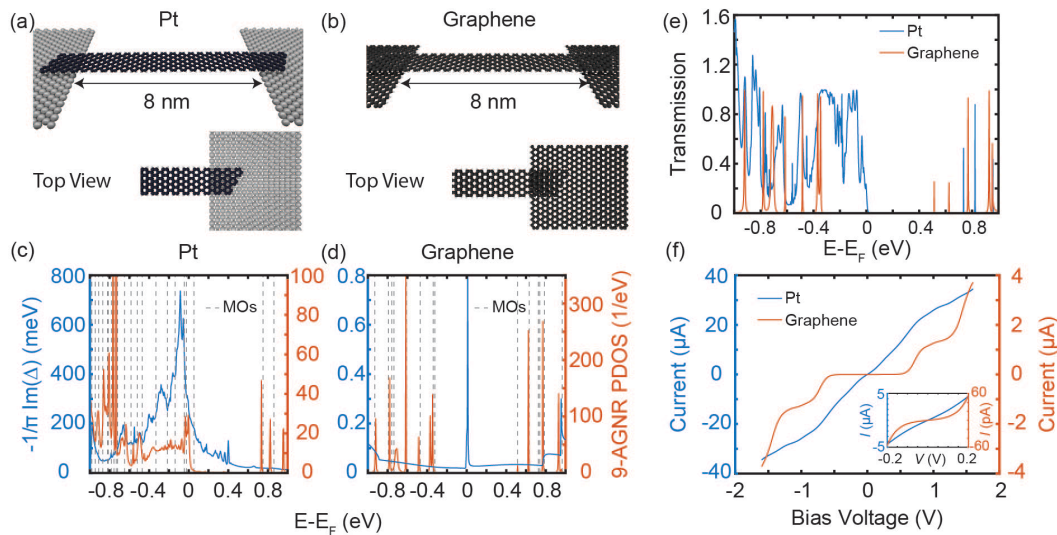


FIG. 5. (a) and (b) Atomic models for 9-AGNR nanogap junctions with platinum and graphene contacts, respectively. (c) and (d) Hybridization function between the GNR and the metallic contacts as a function of energy. The hybridization with platinum is orders of magnitude larger than with graphene, which is reflected in the “broad” PDOS below the Fermi level. For graphene, the PDOS is characterized by sharp peaks directly linkable to the MOs of the dissociated GNR indicating that the molecule is only loosely coupled to the contacts. (e) Electronic transmission as a function of energy. It is characterized by narrow peaks in regions of small hybridization and approaches the idea constant value of 1 when the hybridization increases. (f) Current obtained by integrating the electronic transmission in a bias window centered around the Fermi level. The current for platinum contacts shows the linear behavior observed in experiments. For completeness, we have also included the transmission and current calculations for the case of Pd electrodes in SM.2.1.

To describe the low resistance and nearly linear I - V characteristics of the 9-AGNR junctions, we employed the density functional theory + non-equilibrium Green’s function (DFT + NEGF) method to unveil the origin of this behavior in our 9-AGNR-Pt coupling. Details about the simulations can be found in SM.2.

We consider the atomistic models in Figs. 5(a) and 5(b). They are representative of a 9-AGNR contacted with platinum and graphene, respectively, with the goal of comparing both configurations. The length of the GNR is set to 11 nm and the contacts are separated by an 8-nm gap. For ribbons with atomically precise edges, transport is expected to be ballistic and the conductance should not vary with the distance between the contacts.²⁹ To assess the quality of the latter we compute the hybridization strength of the GNR with the underlying electrodes and report the result in Figs. 5(c) and 5(d). For platinum contacts, the hybridization is large below the Fermi level, i.e., in the valence band (VB) of the GNR but decreases above this energy. This finding is evidenced by the density of states projected onto the GNR (PDOS), which evolves from a continuum of states below in the VB to a series of discrete and narrow peaks above it, directly linkable to the molecular orbital states (MOs) of the uncoupled GNR (vertical dashed lines).

For graphene contacts, on the other hand, the hybridization remains small throughout the energy window relevant for transport and the PDOS strongly resembles the discrete spectrum of the dissociated GNR. This indicates that, upon contact with graphene, the electronic states in the channel remain mostly bounded. The hybridization strength is reflected in the electronic transmission [see Fig. 5(e)], which approaches the ideal constant value of 1 of a perfectly contacted GNR in the regions of large hybridization and reduces to sharp peaks typical of resonant transport otherwise. The current calculated by applying a symmetric bias across the electrodes shows a linear dependence for

platinum contacts within the range of 200 mV, in agreement with experiments [see Figs. 5(f) and 4(a)]. In our calculations, the linear dependence stems from the p -type character of the GNR—any bias window finds some open channels available for transport. Contrarily, the current for graphene contacts shows a nonlinear, step-like behavior typical of molecular junctions in the resonant transport regime in which the central molecule is loosely coupled to the leads.

Our simulation results, thus, indicate that, upon contact with platinum, the GNR MOs strongly hybridize with the underlying material and broaden into a continuous density of channels available for transport. This, in turn, yields devices with low contact resistance and nearly linear I - V characteristic.

In summary, we fabricate 9-AGNR field effect transistor devices with Pt contacts by employing a polymer-free transfer technique subsequent to the deposition of electrical contacts. The GNR devices, ranging from 20 to 100 nm in gap width, consistently show a low-bias resistance value, $R \approx 10^7 \Omega$, orders of magnitude lower than previous reports. The high-current level indicates that Pt electrodes with polymer-free transfer are a great platform for contacting 9-AGNR. DFT + NEGF calculations demonstrate that Pt contact leads to a higher transmission than other materials, such as graphene. This not only explains the I - V characteristics and p -type transport observed in the experiments but also points out that Pt is a good contact material for a transparent contact interface.

See the [supplementary material](#) for more experimental results (SM.1); the STM and Raman characterizations of the 9-AGNRs (SM.1.1); the additional experimental data with PMMA transfer (SM.1.2); the additional electrical characterizations of the 9-AGNRs shown in the main text (SM.1.3–SM.1.5); the theoretical method (SM.2); and the calculation for electronic transport for Pd electrodes (SM.2.1).

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AUTHOR DECLARATIONS

Conflict of Interest

The authors have no conflicts to disclose.

Author Contributions

Chunwei Hsu: Conceptualization (equal); Methodology (equal); Validation (equal); Visualization (equal); Writing – original draft (equal); Writing – review & editing (equal). **Maria El Abbassi:** Conceptualization (equal); Methodology (equal); Supervision (equal); Validation (equal); Writing – original draft (equal); Writing – review & editing (equal). **Michael Rohde:** Data curation (equal); Formal analysis (lead); Visualization (equal); Writing – original draft (equal); Writing – review & editing (equal). **Gabriela Borin Barin:** Resources (lead); Writing – original draft (equal); Writing – review & editing (equal). **Guido Gandus:** Formal analysis (equal); Methodology (equal); Writing – original draft (equal); Writing – review & editing (equal). **Daniele Passerone:** Supervision (equal); Writing – original draft (equal); Writing – review & editing (equal). **Mathieu Luisier:** Funding acquisition (equal); Supervision (equal); Writing – original draft (equal); Writing – review & editing (equal). **Pascal Ruffieux:** Funding acquisition (equal); Resources (equal); Supervision (equal); Writing – original draft (equal); Writing – review & editing (equal). **Roman Fasel:** Funding acquisition (equal); Resources (equal); Supervision (equal); Writing – original draft (equal); Writing – review & editing (equal). **Herre S. J. van der Zant:** Funding acquisition (equal); Methodology (equal); Resources (equal); Supervision (equal); Writing – original draft (equal); Writing – review & editing (equal).

DATA AVAILABILITY

The data that support the findings of this study are available from the corresponding author upon reasonable request.

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